

N-Channel Enhancement Mode Power MOSFET

Description

The HM60N04 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

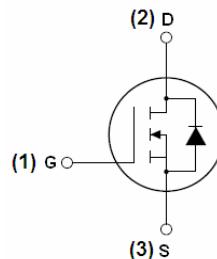
- $V_{DS} = 40V, I_D = 60A$
- $R_{DS(ON)} < 13m\Omega @ V_{GS}=10V$
- High density cell design for ultra low $R_{DS(on)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

Application

- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply

100% UIS TESTED!

100% ΔV_{ds} TESTED!



Schematic diagram



Marking and pin assignment



TO-220-3L top view

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|---------|----------------|-----------|------------|----------|
| HM60N04 | HM60N04 | TO-220-3L | - | - | - |

Absolute Maximum Ratings ($T_c=25^\circ C$ unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|---------------------|------------|---------------|
| Drain-Source Voltage | V_{DS} | 40 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous | I_D | 60 | A |
| Drain Current-Continuous($T_c=100^\circ C$) | $I_D (100^\circ C)$ | 42 | A |
| Pulsed Drain Current | I_{DM} | 200 | A |
| Maximum Power Dissipation | P_D | 65 | W |
| Derating factor | | 0.43 | W/ $^\circ C$ |
| Single pulse avalanche energy (Note 5) | E_{AS} | 400 | mJ |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55 To 175 | $^\circ C$ |

Thermal Characteristic

| | | | |
|--|------------------|-----|------|
| Thermal Resistance, Junction-to-Case ^(Note 2) | R _{θJC} | 2.3 | °C/W |
|--|------------------|-----|------|

Electrical Characteristics (T_C=25°C unless otherwise noted)

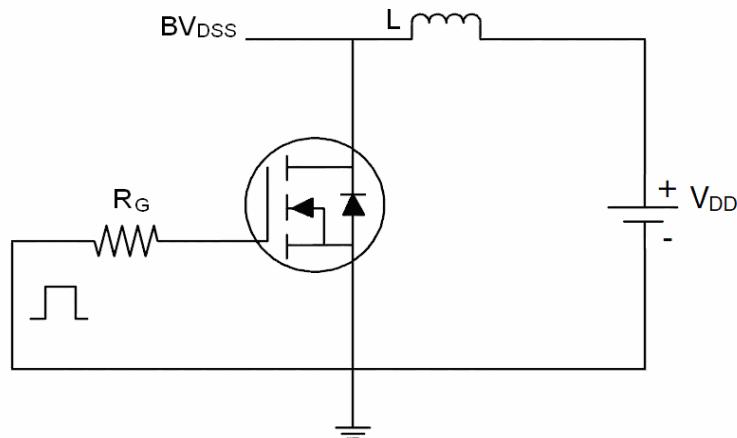
| Parameter | Symbol | Condition | Min | Typ | Max | Unit |
|--|---------------------|--|-----|------|------|------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V I _D =250μA | 40 | 45 | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =40V, V _{GS} =0V | - | - | 1 | μA |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±20V, V _{DS} =0V | - | - | ±100 | nA |
| On Characteristics ^(Note 3) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} =V _{GS} , I _D =250μA | 1.2 | 1.6 | 2.5 | V |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =20A | - | 7.3 | 13 | mΩ |
| Forward Transconductance | g _{FS} | V _{DS} =10V, I _D =20A | 15 | - | - | S |
| Dynamic Characteristics ^(Note 4) | | | | | | |
| Input Capacitance | C _{iss} | V _{DS} =20V, V _{GS} =0V, F=1.0MHz | - | 1800 | - | PF |
| Output Capacitance | C _{oss} | | - | 280 | - | PF |
| Reverse Transfer Capacitance | C _{rss} | | - | 190 | - | PF |
| Switching Characteristics ^(Note 4) | | | | | | |
| Turn-on Delay Time | t _{d(on)} | V _{DD} =20V, I _D =2A, R _L =1Ω V _{GS} =10V, R _G =3Ω | - | 6.4 | - | nS |
| Turn-on Rise Time | t _r | | - | 17.2 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | | - | 29.6 | - | nS |
| Turn-Off Fall Time | t _f | | - | 16.8 | - | nS |
| Total Gate Charge | Q _g | V _{DS} =20V, I _D =20A, V _{GS} =10V | - | 29 | - | nC |
| Gate-Source Charge | Q _{gs} | | - | 4.5 | - | nC |
| Gate-Drain Charge | Q _{gd} | | - | 6.4 | - | nC |
| Drain-Source Diode Characteristics | | | | | | |
| Diode Forward Voltage ^(Note 3) | V _{SD} | V _{GS} =0V, I _S =10A | - | | 1.2 | V |
| Diode Forward Current ^(Note 2) | I _S | | - | - | 60 | A |
| Reverse Recovery Time | t _{rr} | T _J = 25°C, IF = 20A di/dt = 100A/μs ^(Note 3) | - | 29 | - | nS |
| Reverse Recovery Charge | Q _{rr} | | - | 26 | - | nC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) | | | | |

Notes:

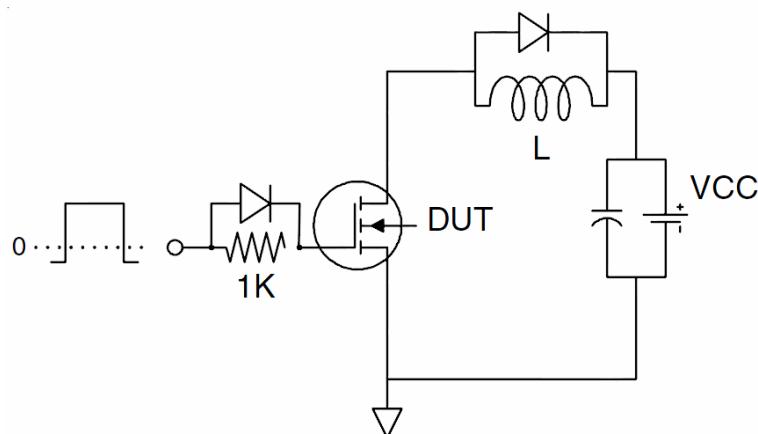
1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, t ≤ 10 sec.
3. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
4. Guaranteed by design, not subject to production
5. E_{AS} condition : T_j=25°C, V_{DD}=20V, V_G=10V, L=1mH, R_g=25Ω,

Test circuit

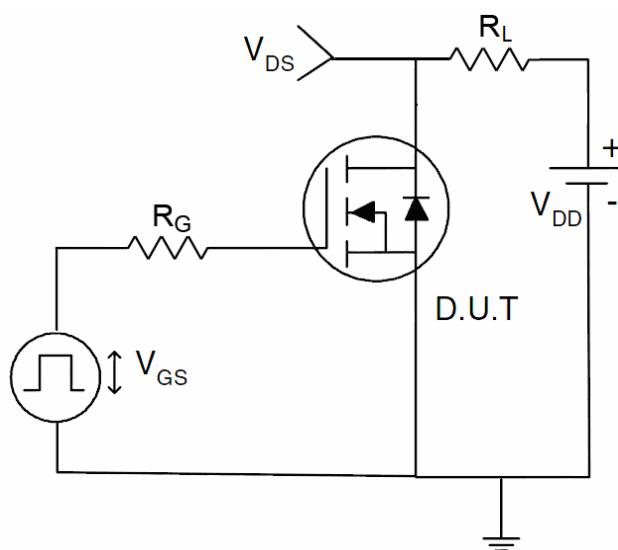
1) E_{AS} Test Circuit



2) Gate Charge Test Circuit



3) Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)

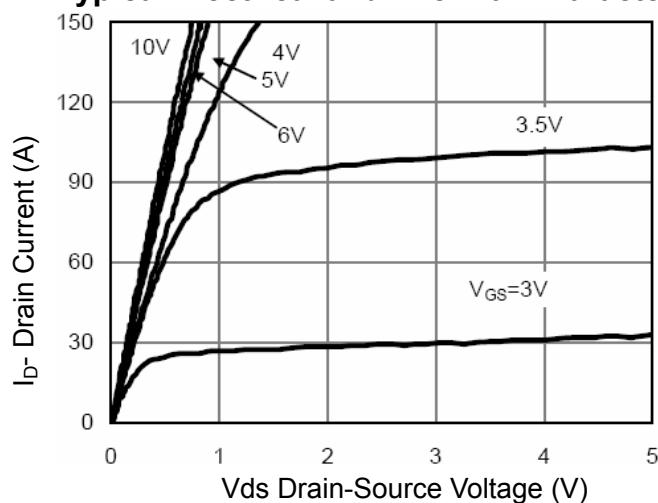


Figure 1 Output Characteristics

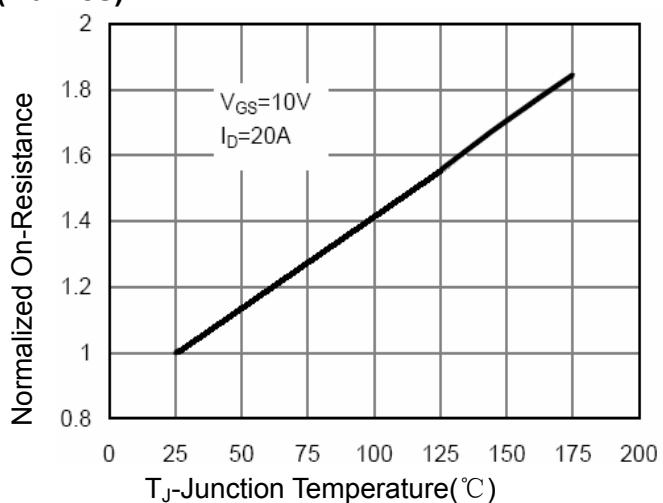


Figure 4 Rdson-JunctionTemperature

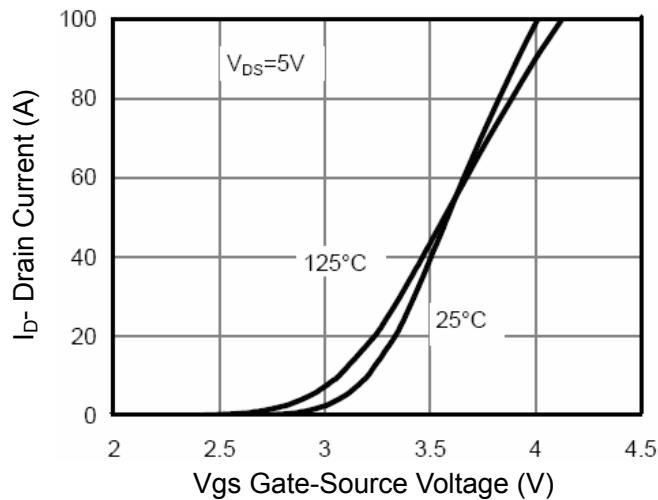


Figure 2 Transfer Characteristics

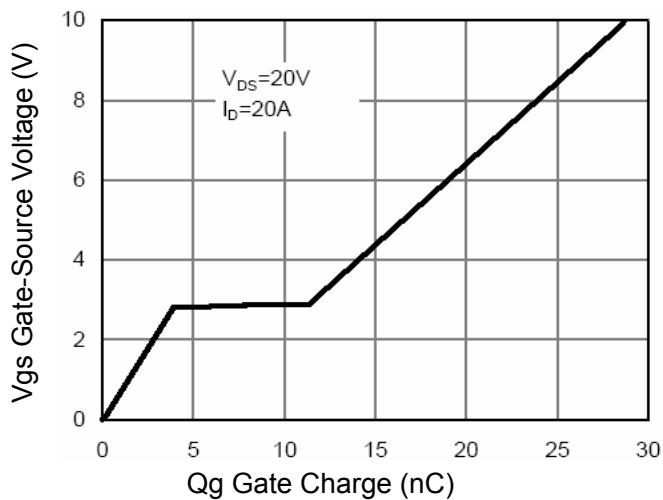


Figure 5 Gate Charge

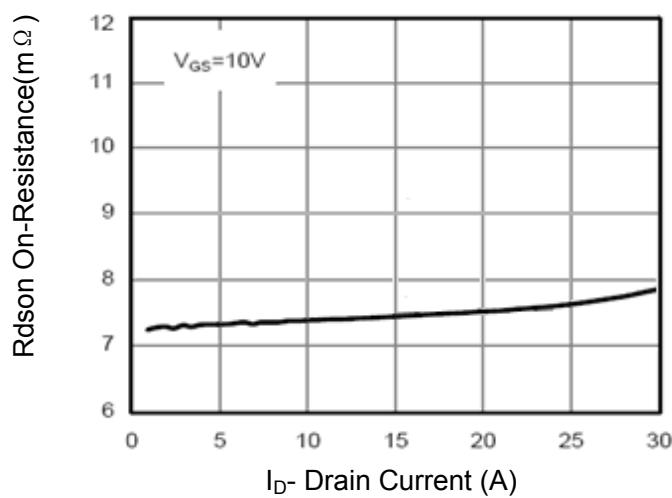


Figure 3 Rdson- Drain Current

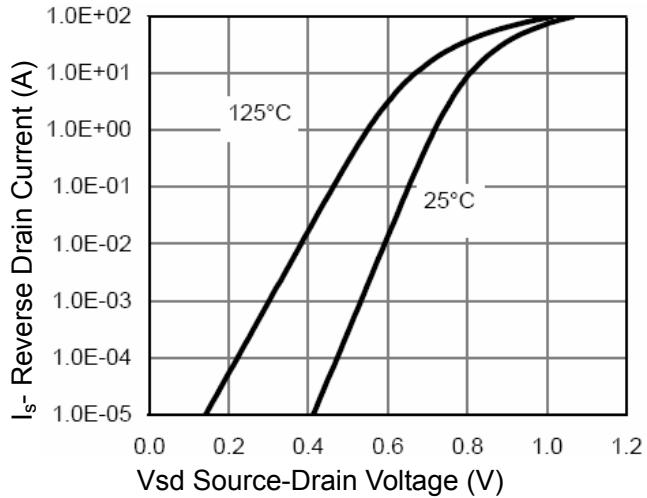


Figure 6 Source- Drain Diode Forward

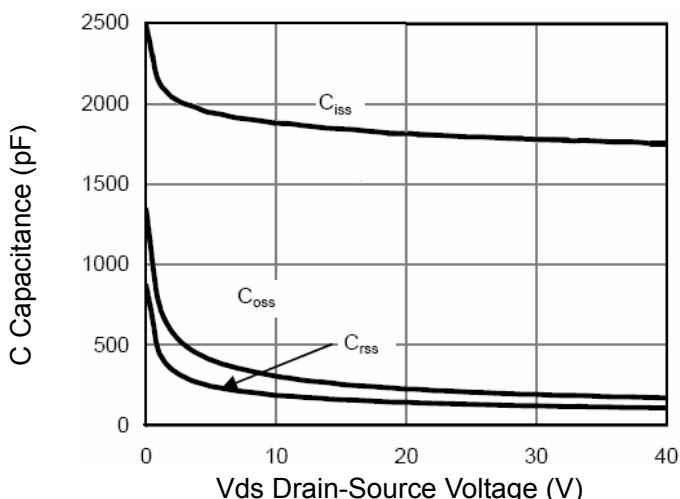


Figure 7 Capacitance vs Vds

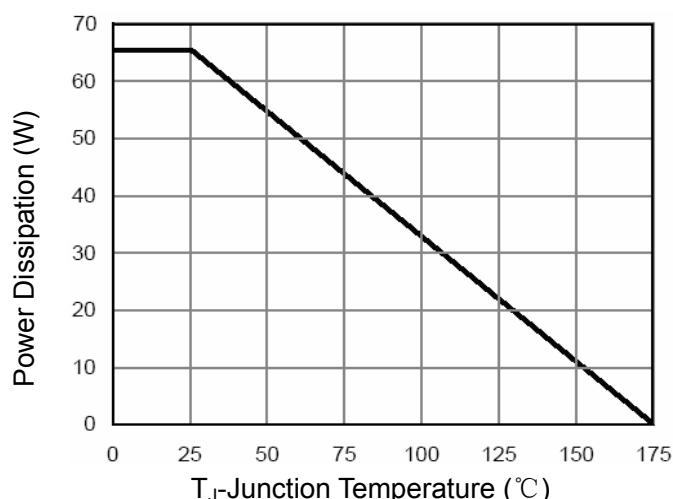


Figure 9 Power De-rating

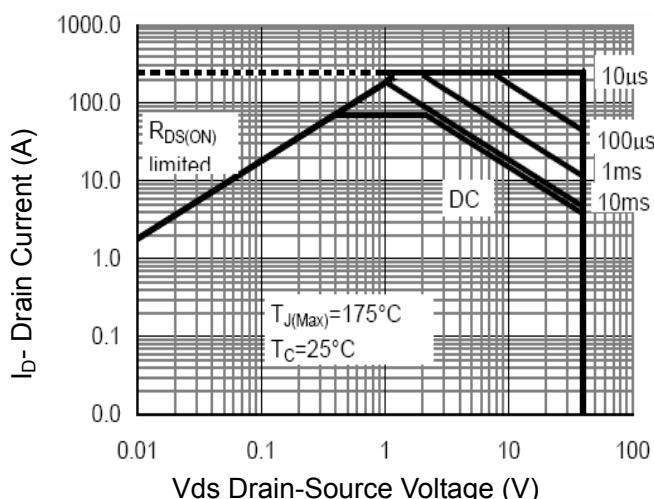


Figure 8 Safe Operation Area

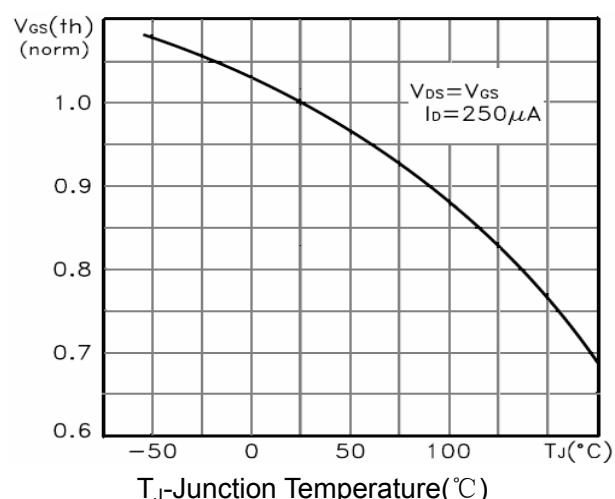


Figure 10 $V_{GS(th)}$ vs Junction Temperature

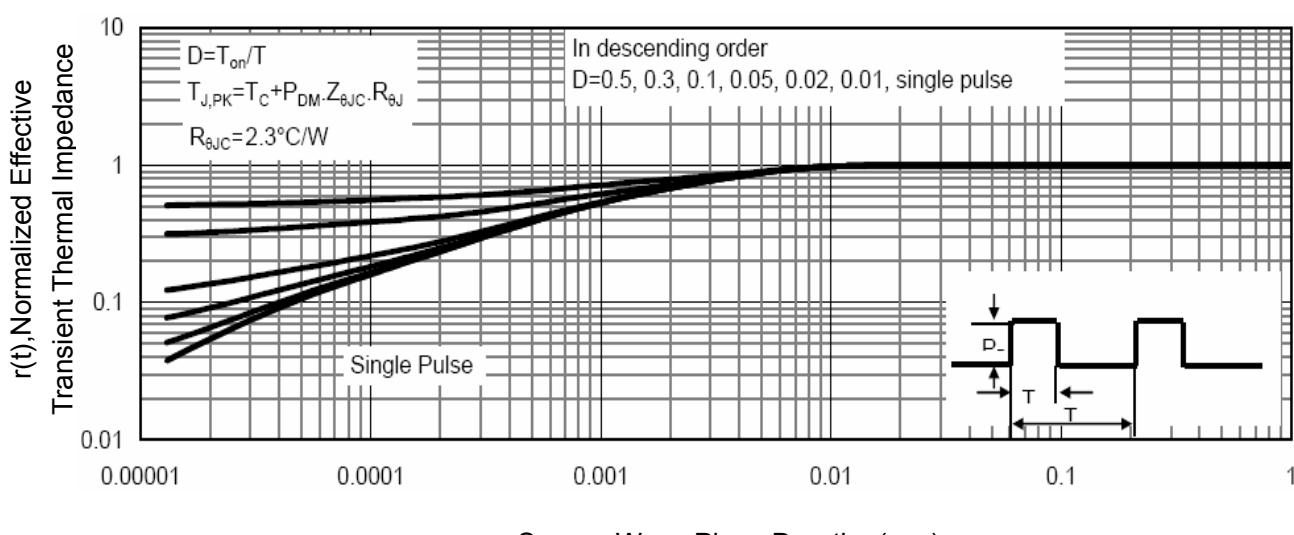
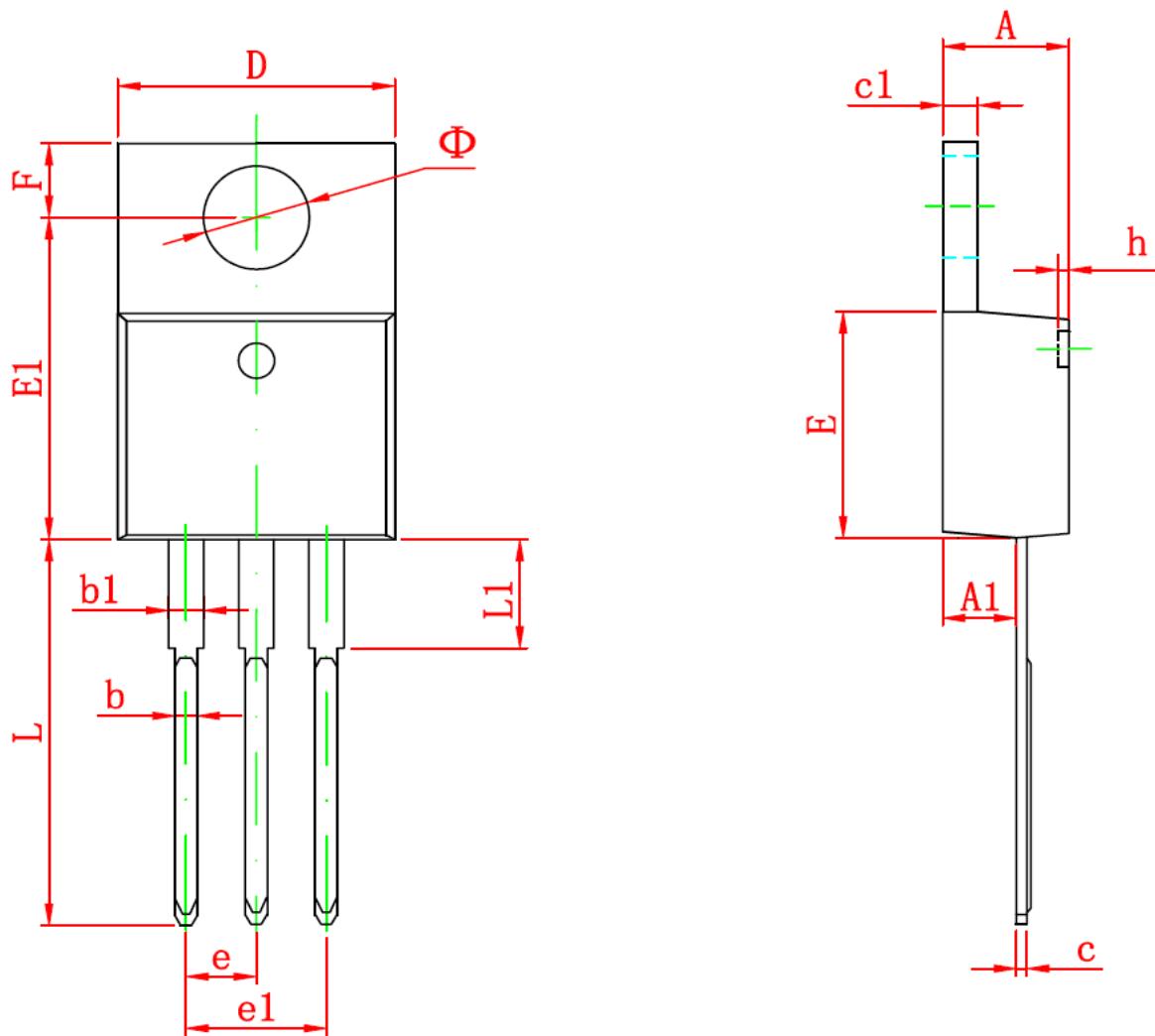


Figure 11 Normalized Maximum Transient Thermal Impedance

TO-220-3L PACKAGE OUTLINE DIMENSIONS



| Symbol | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|--------|----------------------|-------|
| | Min | Max | Min | Max |
| A | 4.470 | 4.670 | 0.176 | 0.184 |
| A1 | 2.520 | 2.820 | 0.099 | 0.111 |
| b | 0.710 | 0.910 | 0.028 | 0.036 |
| b1 | 1.170 | 1.370 | 0.046 | 0.054 |
| c | 0.310 | 0.530 | 0.012 | 0.021 |
| c1 | 1.170 | 1.370 | 0.046 | 0.054 |
| D | 10.010 | 10.310 | 0.394 | 0.406 |
| E | 8.500 | 8.900 | 0.335 | 0.350 |
| E1 | 12.060 | 12.460 | 0.475 | 0.491 |
| e | 2.540 TYP | | 0.100 TYP | |
| e1 | 4.980 | 5.180 | 0.196 | 0.204 |
| F | 2.590 | 2.890 | 0.102 | 0.114 |
| h | 0.000 | 0.300 | 0.000 | 0.012 |
| L | 13.400 | 13.800 | 0.528 | 0.543 |
| L1 | 3.560 | 3.960 | 0.140 | 0.156 |
| Φ | 3.735 | 3.935 | 0.147 | 0.155 |